

Search Notes

Application/Control No.

10/627,563

Examiner

Shih-Chao Chen

Applicant(s)/Patent under
Reexamination

LEWRY ET AL.

Art Unit

2821

SEARCHED

Class	Subclass	Date	Examiner
343	781CA, 781P, 837, 840	4/29/2005	CHEN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (search items: reflector, subreflector, wveguide, feed, hub, dielectric).	4/29/2005	CHEN